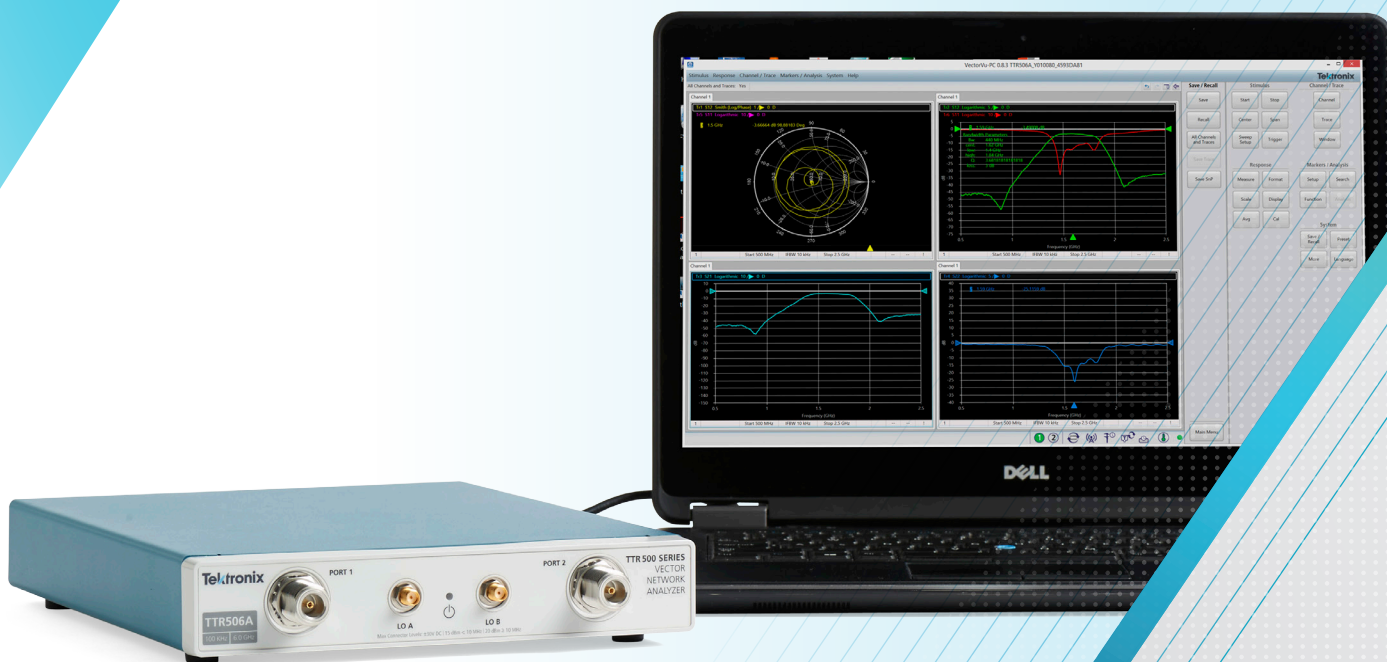


# Vector Network Analyzer Fundamentals

---

POSTER





# Vector Network Analyzer Fundamentals



## Types of Measurement Error

WARNING: To reduce errors that affect measurement results, it is important to calibrate a VNA setup regularly. Calibration reduces the impact of systematic and drift errors.

SYSTEMATIC ERROR	RANDOM ERROR	DRIFT ERROR
<ul style="list-style-type: none"><li>Imperfections in the test equipment or in the test setup</li><li>Typically predictable</li><li>Can be easily factored out by a user calibration</li><li>Examples that occur across the frequency range:<ul style="list-style-type: none"><li>Output power variations</li><li>Ripples in the VNA receiver's frequency response</li><li>Power loss of RF cables that connect the DUT to the VNA</li></ul></li></ul>	<ul style="list-style-type: none"><li>Error caused by noise emitted from the test equipment or test setup that varies with time</li><li>Determines the degree of accuracy that can be achieved in your measurement</li><li>Cannot be factored out by a user calibration</li><li>Examples include:<ul style="list-style-type: none"><li>Trace noise</li></ul></li></ul>	<ul style="list-style-type: none"><li>Measurement drift and variances that occur over time in test equipment and test setup after a user calibration</li><li>The amount that the test setup drifts over time determines how often your test setup needs to be recalibrated</li><li>Examples include:<ul style="list-style-type: none"><li>Temperature changes</li><li>Humidity changes</li><li>Mechanical movement of the setup</li></ul></li></ul>

## Understanding VNA Calibration

### Factory Calibration

- Covers up to the Port 1 and Port 2 connectors
- Ensures output signals meet specs and input signals will be represented accurately

### User Calibration

- Factors out the effects of cables, adaptors, and most things used in the connection of the DUT
- Allows for exact measurement of the DUT performance alone

## Calibration Methods

Response	2-port One Path	2-port Two Path	Electronic
<p>S11, S21, S12, S22</p>	<p>S11, S21</p>	<p>S11, S21, S12, S22</p>	<p>S11, S21, S12, S22</p>
<ul style="list-style-type: none"><li>Very simple</li><li>Very few connections</li><li>Less accurate</li><li>Inexpensive</li></ul>	<ul style="list-style-type: none"><li>Simple</li><li>Few connections</li><li>Moderately accurate</li><li>Limited S-parameters</li></ul>	<ul style="list-style-type: none"><li>Complex</li><li>Many connections</li><li>Highly accurate</li><li>Full S-parameters</li></ul>	<ul style="list-style-type: none"><li>Very simple</li><li>Very few connections</li><li>Highly accurate</li><li>Expensive</li></ul>

## Basic VNA Operation

A VNA contains both a source, used to generate a known stimulus signal, and a set of receivers, used to determine changes to this stimulus caused by the device-under-test or DUT. This illustration highlights the basic operation of a VNA. For the sake of simplicity, it shows the source coming from Port 1, but most VNAs today are multipath instruments and can provide the stimulus signal to either port.

## S-Parameter Basics

**S-Parameter Definition:** Scattering parameters or S-parameters describe the electrical properties and performance of RF electrical components or networks of components when undergoing various steady state electrical signal stimuli. They are unitless complex numbers, having both magnitude and phase, and are related to familiar measurements such as gain, loss, and reflection coefficient.

### Outside View

### Inside VNA View

### S-Parameter Theory View

Forward:  $S_{11} = \frac{\text{Reflected}}{\text{Incident}} = \frac{b_1}{a_1} \Big|_{a_2=0}$

Reverse:  $S_{22} = \frac{\text{Reflected}}{\text{Incident}} = \frac{b_2}{a_2} \Big|_{a_1=0}$

Transmission:  $S_{21} = \frac{\text{Transmitted}}{\text{Incident}} = \frac{b_2}{a_1} \Big|_{a_2=0}$

Reverse:  $S_{12} = \frac{\text{Transmitted}}{\text{Incident}} = \frac{b_1}{a_2} \Big|_{a_1=0}$

For more information on S-parameters go to [tek.com/VNAprimer](http://tek.com/VNAprimer)

## Smith Chart 101

The Smith chart is a very useful tool used to determine complex impedances and admittances of RF circuits. Most network analyzers can automatically display the Smith chart, plot measured data on it, and provide adjustable markers to show the calculated impedance.

### Impedance ( $Z = R + jX$ )

### Admittance ( $Y = G + jB$ )

### Impedance Smith Chart

- The circles touching the right corner are constant-resistance circles.
- The curves stretching from the right corner to the outer edges of the impedance Smith chart are constant-reactance curves.
- The center of the circle is the  $Z_0$  point. In most cases,  $Z_0 = 50$  ohms. This is also the 20-millisiemens (mS) point.

### Admittance Smith Chart

- The circles in the Smith chart that touch the left corner are constant-conductance circles.
- The curves stretching from the left corner of the Smith chart to the outer edges of the admittance Smith chart are constant-susceptance curves.

## Common S-Parameter Names

<b>Forward reflection coefficient</b> <ul style="list-style-type: none"><li>Input return loss</li><li>Input match</li><li>VSWR</li></ul> <b>S11</b>	<b>Forward transmission coefficient</b> <ul style="list-style-type: none"><li>Gain</li><li>Loss</li></ul> <b>S21</b>
<b>Reverse transmission coefficient</b> <ul style="list-style-type: none"><li>Reverse isolation</li></ul> <b>S12</b>	<b>Reverse reflection coefficient</b> <ul style="list-style-type: none"><li>Output return loss</li><li>Output match</li><li>VSWR</li></ul> <b>S22</b>

## Benchtop performance, at a surprising price.

The TTR500 Series Vector Network Analyzer rivals the leading benchtop competition, at 40% lower cost and one-seventh the size and weight! It has:

- 100 kHz up to 6 GHz frequency range
- >122 dB dynamic range
- <0.008 dBrms trace noise
- 50 to +7 dBm output power
- Bias Tee: 0 to  $\pm 24$  V and 0 to 200 mA

All, backed by Tektronix legendary service, support and quality.

Learn more at: [tek.com/TTR500](http://tek.com/TTR500)



**Tektronix**



## **Contact Information:**

**Australia** 1 800 709 465  
**Austria** 00800 2255 4835  
**Balkans, Israel, South Africa and other ISE Countries** +41 52 675 3777  
**Belgium** 00800 2255 4835  
**Brazil** +55 (11) 3759 7627  
**Canada** 1 800 833 9200  
**Central East Europe / Baltics** +41 52 675 3777  
**Central Europe / Greece** +41 52 675 3777  
**Denmark** +45 80 88 1401  
**Finland** +41 52 675 3777  
**France** 00800 2255 4835  
**Germany** 00800 2255 4835  
**Hong Kong** 400 820 5835  
**India** 000 800 650 1835  
**Indonesia** 007 803 601 5249  
**Italy** 00800 2255 4835  
**Japan** 81 (3) 6714 3010  
**Luxembourg** +41 52 675 3777  
**Malaysia** 1 800 22 55835  
**Mexico, Central/South America and Caribbean** 52 (55) 56 04 50 90  
**Middle East, Asia, and North Africa** +41 52 675 3777  
**The Netherlands** 00800 2255 4835  
**New Zealand** 0800 800 238  
**Norway** 800 16098  
**People's Republic of China** 400 820 5835  
**Philippines** 1 800 1601 0077  
**Poland** +41 52 675 3777  
**Portugal** 80 08 12370  
**Republic of Korea** +82 2 6917 5000  
**Russia / CIS** +7 (495) 6647564  
**Singapore** 800 6011 473  
**South Africa** +41 52 675 3777  
**Spain** 00800 2255 4835  
**Sweden** 00800 2255 4835  
**Switzerland** 00800 2255 4835  
**Taiwan** 886 (2) 2656 6688  
**Thailand** 1 800 011 931  
**United Kingdom / Ireland** 00800 2255 4835  
**USA** 1 800 833 9200  
**Vietnam** 12060128

Rev. 020916

Find more valuable resources at [TEK.COM](http://TEK.COM)

Copyright © 2017, Tektronix. All rights reserved. Tektronix products are covered by U.S. and foreign patents, issued and pending. Information in this publication supersedes that in all previously published material. Specification and price change privileges reserved. TEKTRONIX and TEK are registered trademarks of Tektronix, Inc. All other trade names referenced are the service marks, trademarks or registered trademarks of their respective companies.

03/17 EA 2D-61077-0

